

Notice of References Cited	Application/Control No. 10/506,431	Applicant(s)/Patent Under Reexamination BAEK ET AL.	
	Examiner Yan Chen	Art Unit 2100	Page 1 of 1

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*	A	US-5,949,779	09-1999	Mostafa et al.	370/389
	B	US-			
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	K	US-			
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	M	US-			

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NON-PATENT DOCUMENTS

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